Product data sheet

Product profile

1.1 General description

Dual N-channel enhancement mode Field-Effect Transistor (FET) in a small and leadless ultra thin DFN2020-6 (SOT1118) Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

1.2 Features and benefits

- Very fast switching
- Trench MOSFET technology
- Small and leadless ultra thin SMD plastic package: 2 x 2 x 0.65 mm
- Exposed drain pad for excellent thermal conduction

1.3 Applications

- Charging switch for portable devices
- DC-to-DC converters
- Small brushless DC motor drive
- Power management in battery-driven portables
- Hard disc and computing power management

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Per transistor							
V_{DS}	drain-source voltage	T _j = 25 °C		-	-	30	V
V _{GS}	gate-source voltage			-12	-	12	V
I _D	drain current	V_{GS} = 4.5 V; T_{amb} = 25 °C; $t \le 5$ s	<u>[1]</u>	-	-	4	Α
Static charact	eristics (per transistor)						
R _{DSon}	drain-source on-state resistance	V_{GS} = 4.5 V; I_D = 3.1 A; T_j = 25 °C		-	55	73	mΩ

^[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 6 cm².



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S1	source TR1		D4 D0
2	G1	gate TR1	6 5 4	D1 D2
3	D2	drain TR2		
4	S2	source TR2	7 8	
5	G2	gate TR2		
6	D1	drain TR1	1 2 3	G1 S1 S2 G2
7	D1	drain TR1	Transparent top view	017aaa254
8	D2	drain TR2	SOT1118 (DFN2020-6)	

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PMDPB56XN	DFN2020-6	plastic thermal enhanced ultra thin small outline package; no leads; 6 terminals	SOT1118

4. Marking

Table 4. Marking codes

Type number	Marking code
PMDPB56XN	1N

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
Per transis	tor					
V _{DS}	drain-source voltage	T _j = 25 °C		-	30	V
V_{GS}	gate-source voltage			-12	12	V
I _D	drain current	$V_{GS} = 4.5 \text{ V}; T_{amb} = 25 \text{ °C}; t \le 5 \text{ s}$	[1]	-	4	Α
		V_{GS} = 4.5 V; T_{amb} = 25 °C	[1]	-	3.1	Α
		T _{amb} = 100 °C	<u>[1]</u>	-	1.9	Α
I _{DM}	peak drain current	T_{amb} = 25 °C; single pulse; $t_p \le 10 \mu s$		-	12.4	Α
P _{tot}	total power dissipation	T _{amb} = 25 °C	[2]	-	510	mW
			<u>[1]</u>	-	1165	mW
		T _{sp} = 25 °C		-	8330	mW
Source-dra	nin diode					
Is	source current	T _{amb} = 25 °C	[1]	-	1.2	Α
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Table 5. Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
Per device					
Tj	junction temperature		-55	150	°C
T _{amb}	ambient temperature		-55	150	°C
T _{stg}	storage temperature		-65	150	°C

- [1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 6 cm².
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

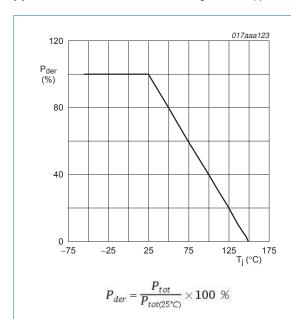


Fig 1. Normalized total power dissipation as a function of junction temperature

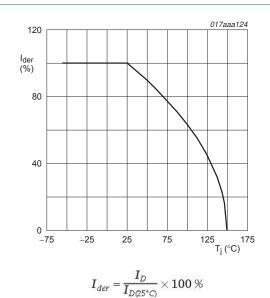


Fig 2. Normalized continuous drain current as a function of junction temperature

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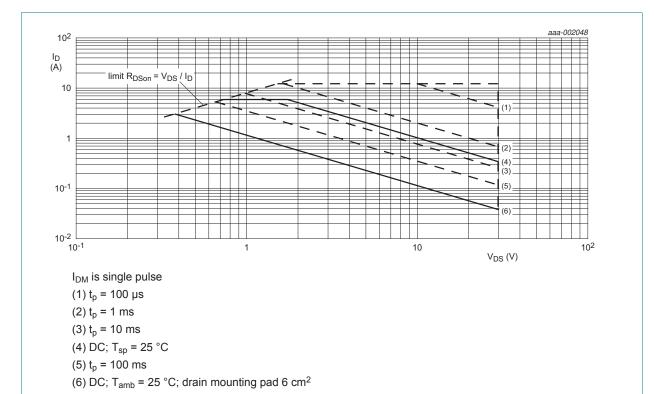


Fig 3. Safe operating area; junction to ambient; continuous and peak drain currents as a function of drain-source voltage

6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Per transistor							
$R_{th(j-a)}$	thermal resistance from junction to ambient		<u>[1]</u>	-	213	245	K/W
			[2]	-	93	107	K/W
		in free air; t ≤ 5 s	[2]	-	55	64	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point			-	12	15	K/W

^[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

 $[\]label{eq:condition} \mbox{[2]} \quad \mbox{Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 6 cm^2.}$

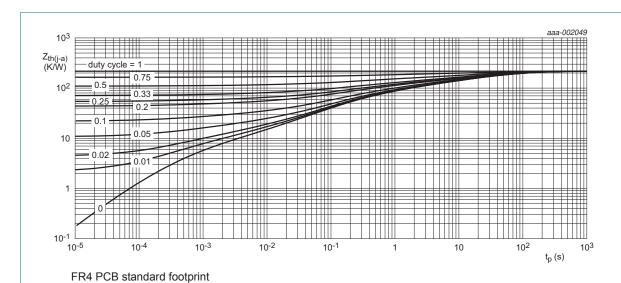


Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

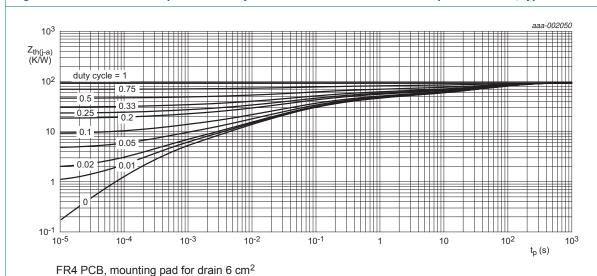


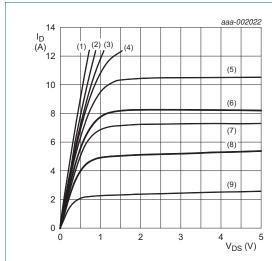
Fig 5. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

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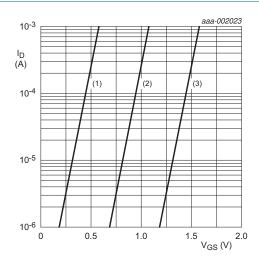
7. Characteristics

Table 7. Characteristics

Table 7.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics (per transistor)					
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$	30	-	-	V
V_{GSth}	gate-source threshold voltage	$I_D = 250 \mu A; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$	0.5	1	1.5	V
I _{DSS}	drain leakage current	V_{DS} = 30 V; V_{GS} = 0 V; T_j = 25 °C	-	-	1	μΑ
		V_{DS} = 30 V; V_{GS} = 0 V; T_j = 150 °C	-	-	20	μΑ
I _{GSS}	gate leakage current	V_{GS} = 12 V; V_{DS} = 0 V; T_j = 25 °C	-	-	100	nA
		V_{GS} = -12 V; V_{DS} = 0 V; T_j = 25 °C	-	-	100	nA
R _{DSon}	drain-source on-state	V_{GS} = 4.5 V; I_{D} = 3.1 A; T_{j} = 25 °C	-	55	73	mΩ
	resistance	V_{GS} = 4.5 V; I_D = 3.1 A; T_j = 150 °C	-	93	123	mΩ
		V_{GS} = 2.5 V; I_D = 0.8 A; T_j = 25 °C	-	86	124	mΩ
g _{fs}	forward transconductance	V_{DS} = 10 V; I_{D} = 3.1 A; T_{j} = 25 °C	-	18	-	S
Dynamic	characteristics (per transist	tor)				
Q _{G(tot)}	total gate charge	V _{DS} = 15 V; I _D = 3.1 A; V _{GS} = 4.5 V;	-	1.9	2.9	nC
Q_{GS}	gate-source charge	T _j = 25 °C	-	0.41	-	nC
Q_{GD}	gate-drain charge		-	0.62	-	nC
C _{iss}	input capacitance	V_{DS} = 15 V; f = 1 MHz; V_{GS} = 0 V;	-	170	-	pF
C _{oss}	output capacitance	T _j = 25 °C	-	35	-	pF
C _{rss}	reverse transfer capacitance		-	15	-	pF
t _{d(on)}	turn-on delay time	V_{DS} = 15 V; I_{D} = 3.1 A; V_{GS} = 4.5 V;	-	8	-	ns
t _r	rise time	$R_{G(ext)} = 6 \Omega; T_j = 25 ^{\circ}C$	-	17	-	ns
t _{d(off)}	turn-off delay time		-	12	-	ns
t _f	fall time		-	11	-	ns
Source-d	rain diode (per transistor)					
V_{SD}	source-drain voltage	I _S = 1.2 A; V _{GS} = 0 V; T _i = 25 °C	-	8.0	1.2	V

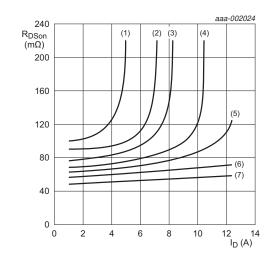


- (1) $V_{GS} = 4.5 \text{ V}$
- $(2) V_{GS} = 3.6 V$
- $(3) V_{GS} = 3.2 V$
- $(4) V_{GS} = 3.0 V$
- $(5) V_{GS} = 2.8 V$
- (6) $V_{GS} = 2.6 \text{ V}$
- $(7) V_{GS} = 2.5 V$
- (8) $V_{GS} = 2.3 \text{ V}$ (9) $V_{GS} = 2.0 \text{ V}$
- Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values



- $T_i = 25 \,^{\circ}\text{C}; \, V_{DS} = 5 \,^{\circ}\text{V}$
- (1) minimum values
- (2) typical values
- (3) maximum values

Fig 7. Sub-threshold drain current as a function of gate-source voltage



 $T_i = 25 \,^{\circ}C$

(1) $V_{GS} = 2.3 \text{ V}$

 $(2) V_{GS} = 2.5 V$

 $(3) V_{GS} = 2.6 V$

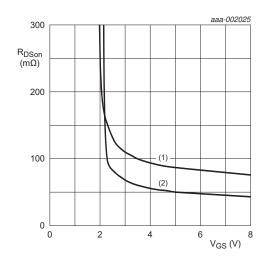
(4) $V_{GS} = 2.8 \text{ V}$

 $(5) V_{GS} = 3.0 V$

(6) $V_{GS} = 3.6 \text{ V}$

 $(7) V_{GS} = 4.5 V$





 $I_D = 3.1 A$

(1) $T_j = 150 \, ^{\circ}C$

(2) $T_j = 25 \, ^{\circ}C$



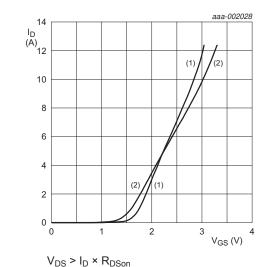


Fig 10. Transfer characteristics: drain current as a function of gate-source voltage; typical values

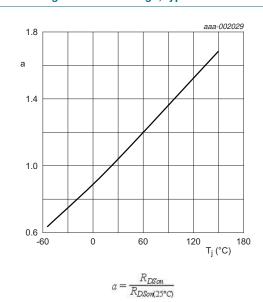
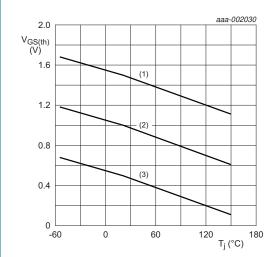


Fig 11. Normalized drain-source on-state resistance as a function of junction temperature; typical values

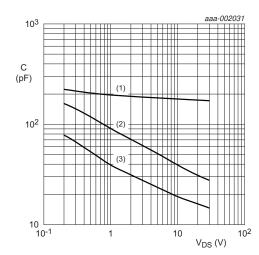
(1) $T_j = 25 \,^{\circ}\text{C}$ (2) $T_i = 150 \,^{\circ}\text{C}$



 $I_D = 3.1 A; V_{DS} = V_{GS}$

- (1) maximum values
- (2) typical values
- (3) minimum values

Fig 12. Gate-source threshold voltage as a function of junction temperature



 $f = 1 MHz; V_{GS} = 0 V$

- (1) C_{iss}
- (2) Coss
- (3) C_{rss}

Fig 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

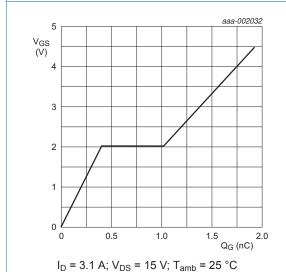


Fig 14. Gate-source voltage as a function of gate charge; typical values

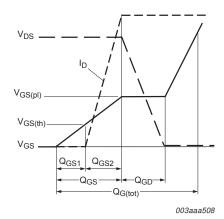
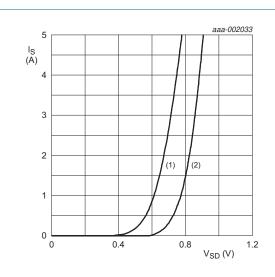


Fig 15. Gate charge waveform definitions



 $V_{GS} = 0 V$

(1) $T_j = 150 \, ^{\circ}C$

(2) $T_i = 25 \,^{\circ}C$

Fig 16. Source current as a function of source-drain voltage; typical values

8. Test information

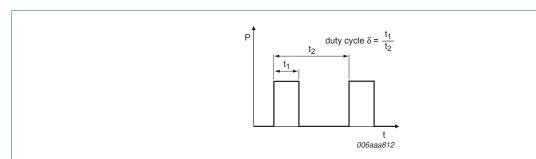
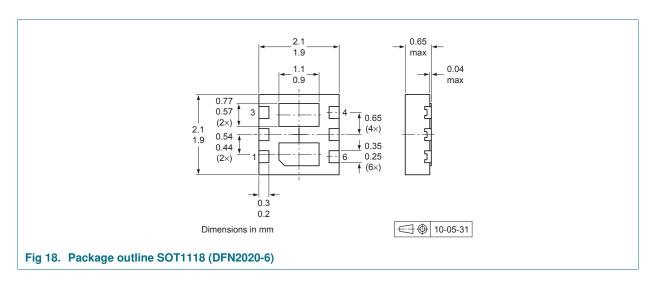
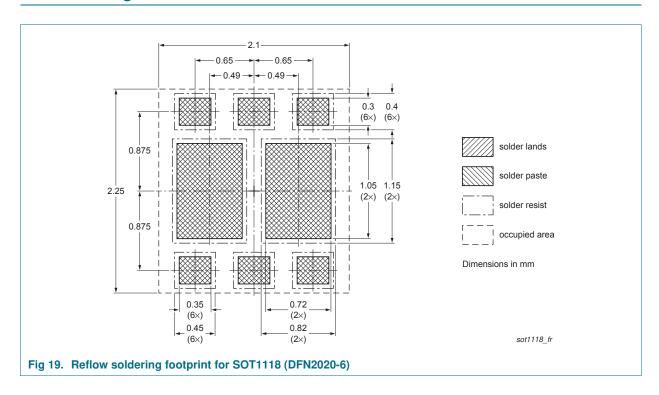


Fig 17. Duty cycle definition

9. Package outline



10. Soldering





11. Revision history

Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PMDPB56XN v.1	20120516	Product data sheet	-	-

12. Legal information

12.1 Data sheet status

Document status[1] [2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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